

FCMT199N60 N-Channel SuperFET[®] II MOSFET

600 V, 20.2 A, 199 mΩ

Features

- 650 V @ T_J = 150°C
- R_{DS(on)} = 170 mΩ (Typ.)
- Ultra Low Gate Charge (Typ. Q_g = 57 nC)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 160 pF)
- 100% Avalanche Tested
- RoHS Compliant

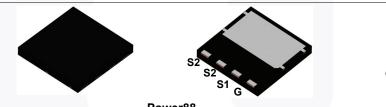
Applications

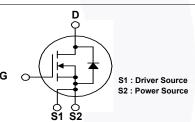
- Server and Telecom Power Supplies
- Solar Inverters
- Adaptors

Description

SuperFET[®] II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET is very suitable for the switching power applications such as server/telecom power, adaptor and solar inverter applications.

The Power88 package is an ultra-slim surface-mount package (1 mm high) with a low profile and small footprint (8x8 mm²). SuperFET II MOSFET in a Power88 package offers excellent switching performance due to lower parasitic source inductance and separated power and drive sources. Power88 offers Moisture Sensitivity Level 1 (MSL 1).





Power88

Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		FCMT199N60	Unit		
V _{DSS}	Drain to Source Voltage				
V _{GSS}	Cata ta Sauraa Valtaga	-DC	-DC		
	Gate to Source Voltage	-AC	(f > 1 Hz)	±30	- V
ID	Drain Current	-Continuous (T _C = 25 ^o C)	-Continuous (T _C = 25 ^o C)		
		-Continuous (T _C = 100 ^o C)		12.7	A
I _{DM}	Drain Current	- Pulsed	(Note 1)	60.6	А
E _{AS}	Single Pulsed Avalanche Ene	400	mJ		
I _{AR}	Avalanche Current	4.0	А		
E _{AR}	Repetitive Avalanche Energy	2.1	mJ		
dv/dt	Peak Diode Recovery dv/dt	20	V/ns		
	MOSFET dv/dt			100	V/ns
P _D	Dewer Dissignation	(T _C = 25°C)		208	W
	Power Dissipation	- Derate above 25°C		1.67	W/ºC
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C
TL	Maximum Lead Temperature	for Soldering, 1/8" from Case for 5 Se	econds	300	°C

Thermal Characteristics

Symbol	Parameter	FCMT199N60	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.6	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient (* 1 in ² pad of 2 oz copper), Max.	45	-0/10

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Device M	<u> </u>		Packa	ackage Reel Size Ta lower88 -		ape Width		Quantity		
FCMT19			Powe			-		3000		
Electrica	l Chara	acteristics T _c = 2	25ºC unless c	otherwise no	oted.					
Symbol		Parameter		т	est Conditions		Min.	Тур.	Max.	Unit
Off Charac	teristics	6								
			14	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 10 \text{ mA}, \text{ T}_{C} = 25^{\circ}\text{C}$ $V_{GS} = 0 \text{ V}, \text{ I}_{D} = 10 \text{ mA}, \text{ T}_{C} = 150^{\circ}\text{C}$ $I_{D} = 10 \text{ mA}, \text{ Referenced to } 25^{\circ}\text{C}$			600	-	-	
BV _{DSS}	Drain to	Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient					650	-	-	V
ΔΒV _{DSS} / ΔΤ _J							-	0.67	-	V/°C
	Zero Ga	Gate Voltage Drain Current			V, V _{GS} = 0 V		-	-	1	μA
DSS					V, V_{GS} = 0 V, T_{C} =	125°C	-	2.2	-	μΑ
I _{GSS}	Gate to	Body Leakage Current		$V_{GS} = \pm 20$	V, V _{DS} = 0 V		-	-	±100	nA
On Charac	teristics	5								
V _{GS(th)}	Gate Th	reshold Voltage		$V_{GS} = V_{DS}$, I _D = 250 μA		2.5	-	3.5	V
R _{DS(on)}	Static D	rain to Source On Resis	stance		/, I _D = 10 A		-	0.170	0.199	Ω
9 _{FS}	Forward Transconductance				/, I _D = 10 A		-	20	-	S
C _{iss} C _{oss}	Input Capacitance Output Capacitance			V _{DS} = 380 f = 1 MHz	V, V _{GS} = 0 V	-	-	2043 45	2715 60	pF pF
C _{rss}		Transfer Capacitance				-	7	-	pF	
C _{oss} eff.		Output Capacitance		$V_{DS} = 0 V \text{ to } 480 V, V_{GS} = 0 V$ $V_{DS} = 380 V, I_D = 10 A$ $V_{GS} = 10 V$ (Note 4) $f = 1 \text{ MHz}$		-	160	- 74	pF	
Q _{g(tot)}		te Charge at 10V				-	57 9	74	nC nC	
Q _{gs}		Source Gate Charge Drain "Miller" Charge	-			-	21	-	nC	
Q _{gd} ESR		ent Series Resistance	-			-	1	-	Ω	
	1 .						-	1	-	52
Switching	-								I	1
t _{d(on)}		Delay Time		$V_{DD} = 380 \text{ V}, \text{ I}_{D} = 10 \text{ A}$ $V_{GS} = 10 \text{ V}, \text{ R}_{g} = 4.7 \Omega$		-	20	50	ns	
t _r		Rise Time				-	10	30	ns	
t _{d(off)}		Delay Time				-	64	138	ns	
t _f		Fall Time		(Note 4)			-	5	20	ns
Drain-Sou		e Characteristics								
I _S	Maximum Continuous Drain to Source Di					-	-	20.2	A	
SM	Maximum Pulsed Drain to Source Diode					-	-	60.6	Α	
V _{SD}		Source Diode Forward	Voltage	$V_{GS} = 0 V, I_{SD} = 10 A$			-	-	1.2	V
t _{rr}		Recovery Time Recovery Charge					-	320	-	ns
Q _{rr}				dI _F /dt = 100 A/µs			-	5.1	-	μC

2. I_{AS} = 4 A, R_G = 25 Ω , starting T_J = 25°C 3. I_{SD} ≤ 10 A, di/dt ≤ 200 A/µs, V_{DD} ≤ BV_{DSS}, starting T_J = 25°C

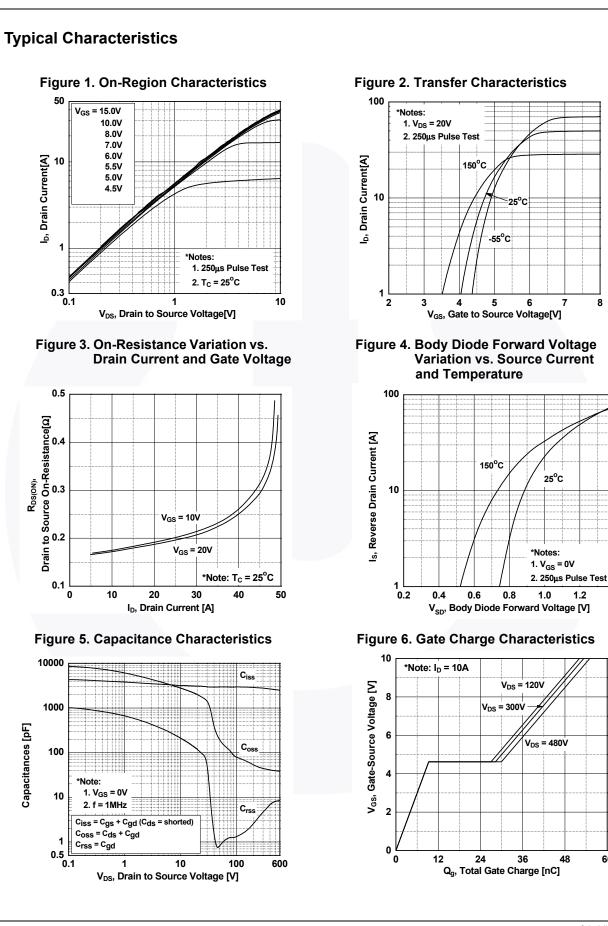
4. Essentially independent of operating temperature typical characteristics.

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1.2

1.4

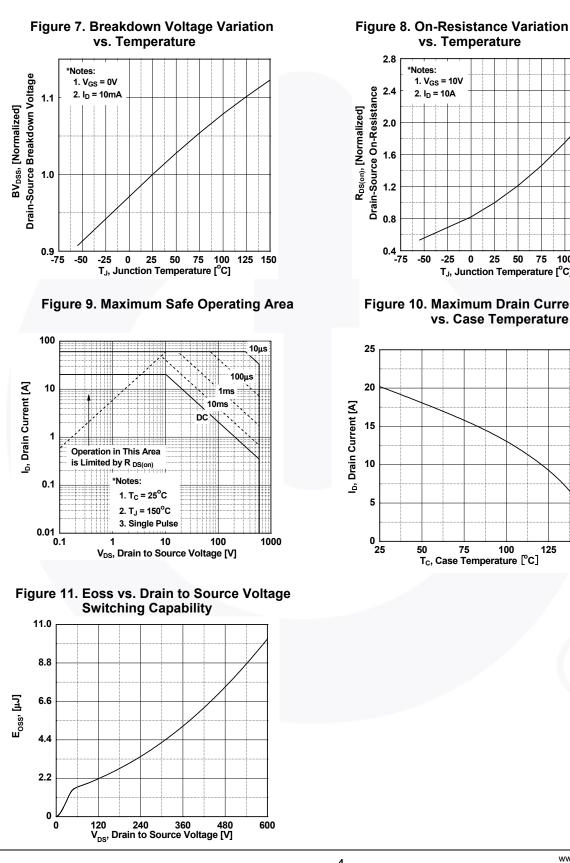
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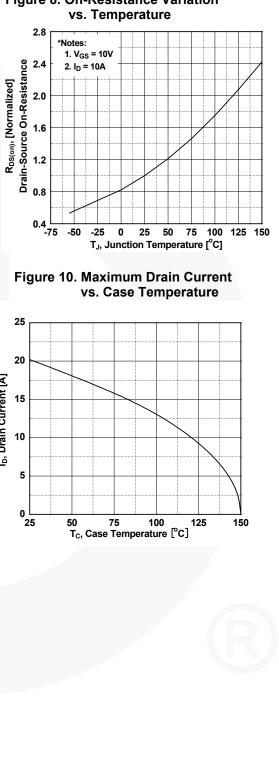
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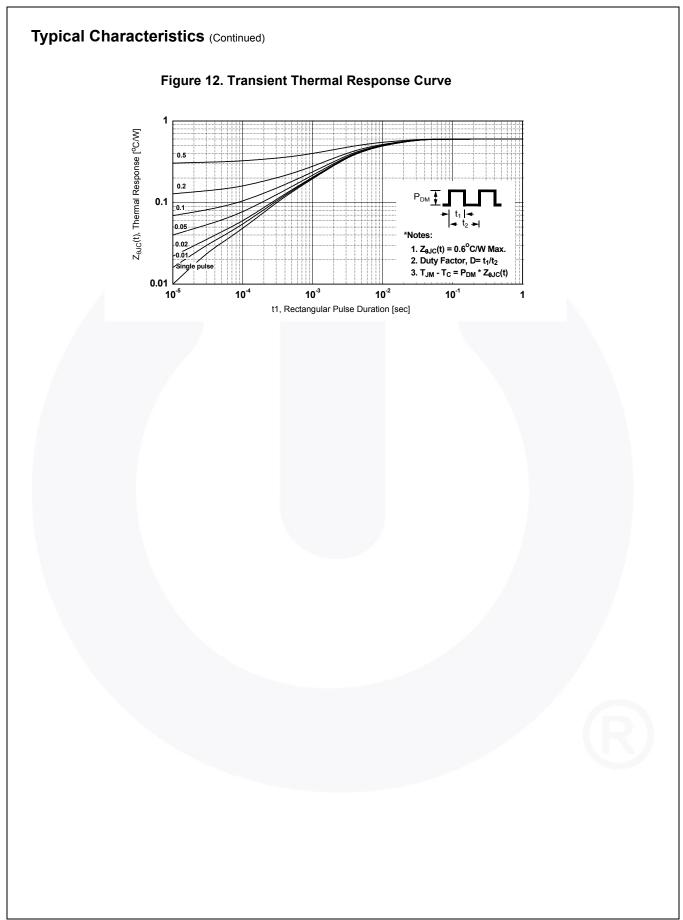
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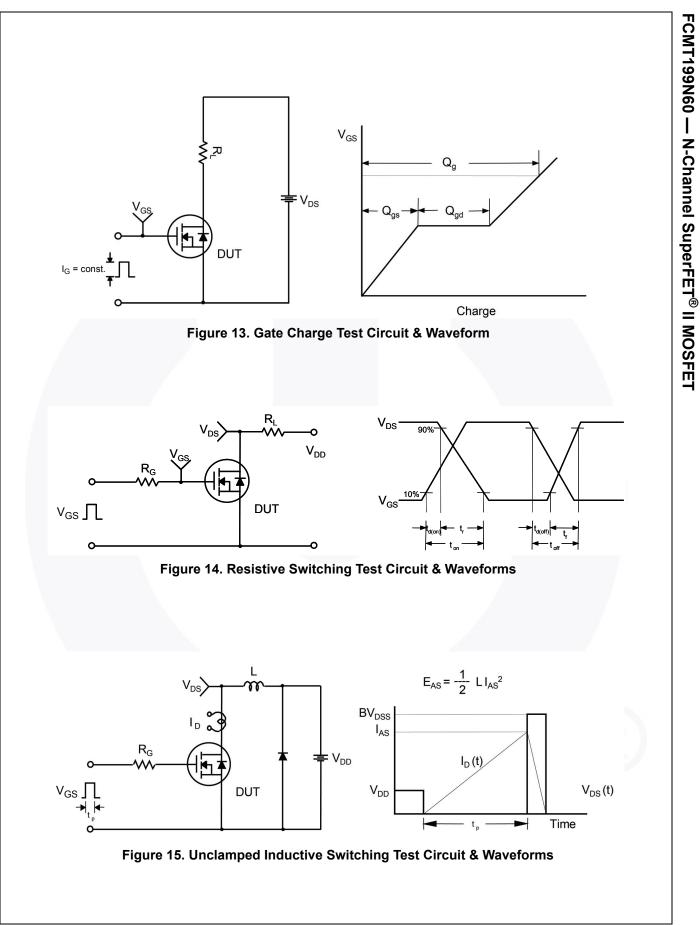




Typical Characteristics (Continued)







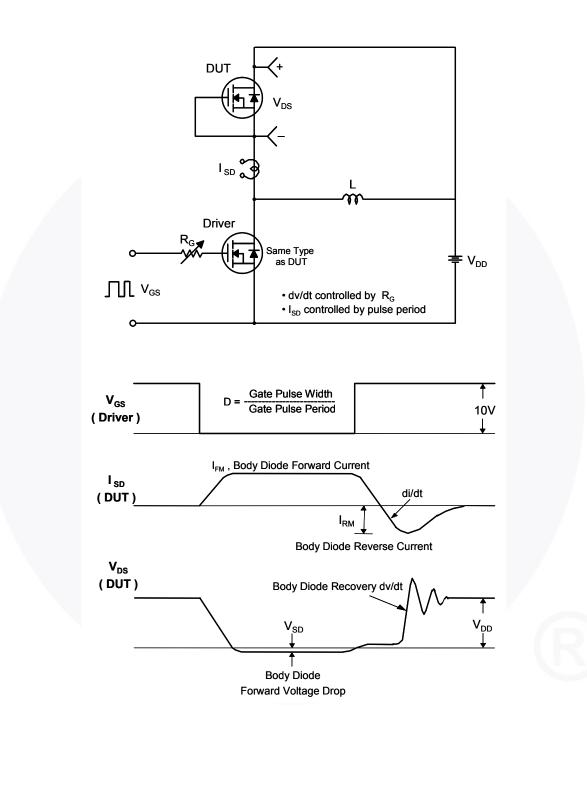
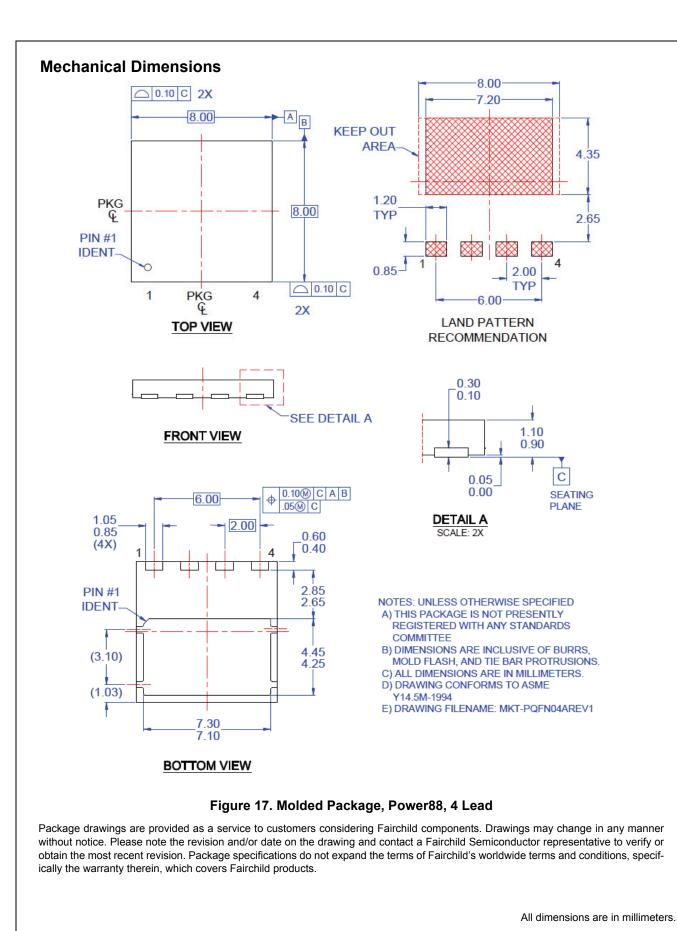
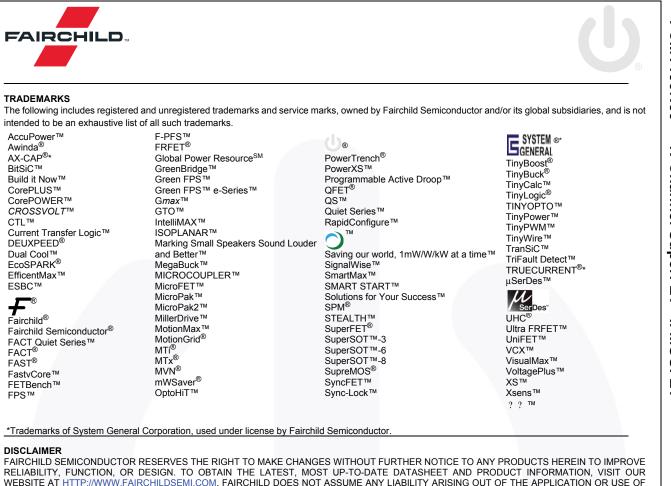


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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